

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10538202	CHANG, CHIN
	Examiner	Art Unit
	Abdi, Amara	2624

SEARCHED

Class	Subclass	Date	Examiner
382	162	11/27/2007	Amara Abdi
345	83	11/27/2007	Amara Abdi
348	272	11/27/2007	Amara Abdi
430	30	11/27/2007	

SEARCH NOTES

Search Notes	Date	Examiner
East: USPAT, US-PGPUB	11/27/2007	Amara Abdi
Google, E-Journal, IEEE explorer, STIC	11/27/2007	Amara Abdi
Consulted with the primary Chen Wenpeng	11/27/2007	Chen Wenpeng

INTERFERENCE SEARCH

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